

Description **Section**



9 samples mounted on a rotating wheel



- The remotely controlled ellipsometer is equipped with 9 samples mounted on a rotating wheel
- Upon selection of one sample, the wheel is automatically rotated to position the selected sample along the path of the laser beam
- An empty space is used to perform transmittance measurements and calibration



Slot 1 – Single AIR / GLASS Interface



- The back face of a thick fused silica plate (h_G = 1 mm) was painted with a black nail-polish to minimize multiple reflections, which can be neglected
- The refractive index of fused silica is about $n_G = 1.47$ at $\lambda = 637$ nm



Slot 2 – Thick membrane



- The membrane is a nitrocellulose film (N-Cell) with refractive index about $n_F = 1.50$ at $\lambda = 637$ nm and thickness about $d_F = 5 \ \mu m$
- The membrane is a commercial uncoated pellicle beamsplitter (Thorlabs)



Slot 3 – ITO thin film on Glass



- The indium tin oxide (ITO) thin film has refractive index about n_{ITO} = 1.78 at λ = 637 nm and thickness about d_{ITO} = 600 nm
- The fused silica substrate is of the same type as in the Slot 1



Slot 4 – Diffraction grating (part of a CD)



- The poly-carbonate (PC) substrate is engraved with lines with period Λ = 1.6 µm. The grating lines are perpendicular to the incidence plane
- The sample was cut from a standard compact disk



Slot 5 – Single Linear Slit



• The slit is constituted by two razor blades at an unknown distance D



Slot 6 – 100 Silicon wafer



- 100 Silicon wafer with thickness h_{Si} = 250 μ m and refractive index about n_{Si} = 3.88 at λ = 637 nm
- Due to the absorption at λ = 637 nm multiple reflections are absent



Slot 7 – ITO thin film on a 100 Silicon wafer



- The indium tin oxide (ITO) thin film has refractive index about $n_{ITO} = 1.78$ at $\lambda = 637$ nm and thickness about $d_{ITO} = 600$ nm
- The 100 Silicon wafer is the same as in the slot 6

Slot 8 – Amorphous Silicon Solar Cell



ITO (80 nm) / n-doped amorphous Si (a:Si) (10 nm) / intrinsic a:Si (5 nm) / n-doped Si wafer (250 μ m) / intrinsic a:Si (5 nm) / p-doped a:Si (5 nm) / ITO (80 nm)

Photo-voltaic current measured by means of the two red/black wires



Slot 9 – Gold coated prism



- The BK7 glass prism has refractive index n_{BK7} = 1.515 at λ = 637 nm
- The Gold layer has thickness about d_{Au} = 45 nm and complex refractive index about n_{Au} = 0.18 + i 3.45